

ARTICLE

Open Access

Enhanced blue-light excited cyan-emitting persistent luminescence of $\text{BaLu}_2\text{Al}_2\text{Ga}_2\text{SiO}_{12}:\text{Ce}^{3+}$, Bi^{3+} phosphors for AC-LEDs via defect modulation

Weihong Yuan^{1,2}, Ran Pang¹✉, Shangwei Wang¹, Tao Tan², Chengyu Li^{1,2,3}✉, Chaowei Wang¹ and Hongjie Zhang^{1,3}

Abstract

Alternating current light-emitting diodes (AC-LEDs) have received significant attention from both academia and industry due to their remarkable benefits of more compact volume, cheaper manufacturing cost, greater energy usage efficiency, and longer service life. One of the most significant challenges for AC-LEDs is the flicker effect, which is mainly caused by the unavoidable 5–20 ms dimming time. Aiming to reduce the flicker effect, we designed a series of excellent blue-light excited cyan-emitting persistent luminescence (PersL) phosphors $\text{BaLu}_2\text{Al}_2\text{Ga}_2\text{SiO}_{12}:\text{Ce}^{3+}$, Bi^{3+} via defect engineering of co-doping Bi^{3+} . Interestingly, we found that co-doping Bi^{3+} not only effectively enhanced the PersL intensity, but also regulated the PersL lifetime of this phosphors. As the Bi^{3+} co-doping concentration increases to 0.01, the τ_{80} value (the time when the PersL intensity decreases to 80% of the initial intensity) increases from 0.24 to 19.61 ms, which proves to be effective in compensating the flicker effect of AC-LEDs. A new method of generating white light emission during the dimming time through adding the blue-light excited cyan PersL phosphor to the original orange-red PersL phosphor was proposed and an AC-LED lamp with a decreased percent flicker of 48.15% was fabricated, which is significantly better than the other currently reported AC-LED devices based on PersL phosphors. These results demonstrate that $\text{BaLu}_2\text{Al}_2\text{Ga}_2\text{SiO}_{12}:\text{Ce}^{3+}$, Bi^{3+} might be an attractive material for low-flicker AC-LEDs.

Introduction

After decades of development, white light-emitting diodes (WLEDs) that can directly convert electrical energy into visible light outperform traditional incandescent and fluorescent lamps in the field of lifetime, luminous efficacy, and energy usage^{1,2}. Nowadays, the municipal electric power is supplied in form of alternating current (AC), while most light-emitting diode (LED) semiconductor chips are powered by direct current (DC)³. Based on this situation, the compact AC-DC converter is an important electronic component that converts AC from city power to DC, which can be applied into WLEDs to ensure the operation of DC-LEDs⁴. However, the

conversion from AC to DC consumes nearly 30% of the input electric power^{5,6}. Furthermore, the AC-DC converter raises the price and expands the size, complicating the product appearance. The massive heat generated during the conversion process also causes degradation of the embedded phosphor, which severely shortens the service lifetime of WLEDs^{7,8}. Thus, in view of these shortcomings of DC-LEDs, AC-LEDs have received widespread attention in both academic research and industrial applications owing to their remarkable benefits of more compact volume, cheaper manufacturing cost, greater energy usage efficiency, and longer service life^{9,10}. Despite so many potential advantages, a pressing issue limiting the commercial application of AC-LEDs is the flicker effect, which is mainly caused by the unavoidable 5–20 ms dimming time in each AC cycle. This effect may also induce headaches, eyestrain, and other symptoms in certain people^{11,12}. Consequently, reducing the flicker effect has become the key issue for the further

Correspondence: Ran Pang (pangran@ciac.ac.cn) or Chengyu Li (cyli@ciac.ac.cn)

¹State Key Laboratory of Rare Earth Resource Utilization, Changchun Institute of Applied Chemistry, Chinese Academy of Sciences, Changchun 130022, China

²University of Science and Technology of China, Hefei 230026, China

Full list of author information is available at the end of the article

© The Author(s) 2022



Open Access This article is licensed under a Creative Commons Attribution 4.0 International License, which permits use, sharing, adaptation, distribution and reproduction in any medium or format, as long as you give appropriate credit to the original author(s) and the source, provide a link to the Creative Commons license, and indicate if changes were made. The images or other third party material in this article are included in the article's Creative Commons license, unless indicated otherwise in a credit line to the material. If material is not included in the article's Creative Commons license and your intended use is not permitted by statutory regulation or exceeds the permitted use, you will need to obtain permission directly from the copyright holder. To view a copy of this license, visit <http://creativecommons.org/licenses/by/4.0/>.

applications of AC-LED lighting systems. As we all know, the fabrication of WLEDs generally involves combining LED chips with phosphors, which provides a method to overcome this problem. PersL phosphors can absorb and store excitation energy and then continuously emit luminescence for an appropriate duration from few seconds to several hours after ceasing the irradiation^{13,14}. Considering that PersL phosphors can maintain luminescence for a certain period of time, they have excellent application prospects to minimize the flicker effect of AC-LEDs by employing the PersL to compensate the dark duration^{15,16}. Charging and detrapping are the two fundamental processes involved in the PersL phenomenon^{17,18}. To satisfy the criteria of AC-LED applications, both processes must be taken into account. First, the electron charging process refers to that under high-energy radiation, electrons can be excited from the ground-state energy level of the emission center to the conduction band (CB) and captured by traps. Accordingly, PersL phosphors should have intensified absorption of blue-light to match commercial InGaN chips^{19–21}. Besides, the electron detrapping process is related to the recombination of the trapped electrons with the holes at emission centers, and thus, the depth and concentration of traps should be suitable to ensure strong PersL intensity within a decay time of 5–20 ms.

The strategy of using PersL phosphor to reduce the flicker effect in AC-LEDs was first proposed by our group²². Thereafter, a serial of yellow PersL phosphors excited by blue-light such as $\text{Lu}_2\text{CaMg}_2(\text{Ge}_x\text{Si}_{1-x})_3\text{O}_{12}:\text{Ce}^{3+}$, $\text{Gd}_3\text{Al}_2\text{Ga}_3\text{O}_{12}:\text{Ce}^{3+}$, and $\text{Mg}_3\text{Y}_2(\text{Ge}_x\text{Si}_{1-x})_3\text{O}_{12}:\text{Ce}^{3+}$ have been reported and are expected to be applied in AC-LEDs, and they can reduce the percent flicker to 64.1%, 69%, and 71.7%, respectively^{19–21}. Among them, $\text{Lu}_2\text{CaMg}_2(\text{Ge}_x\text{Si}_{1-x})_3\text{O}_{12}:\text{Ce}^{3+}$ and $\text{Mg}_3\text{Y}_2(\text{Ge}_x\text{Si}_{1-x})_3\text{O}_{12}:\text{Ce}^{3+}$ are focused on their millisecond PersL performance and the results preliminarily demonstrate that millisecond PersL has the potential to compensate for the flicker. Due to the absence of blue-light component during the dimming time, the AC-LEDs fabricated using blue chips and yellow PersL phosphors usually exhibit a severe shortcoming that only yellow light is compensated during the dimming time. White light can be obtained from the AC-LEDs while the voltage is above than the turn-on voltage (V_f), but when the voltage falls below V_f , only yellow light is left. More concretely, the white luminescence of AC-LEDs is momentary rather than constant. To overcome this situation, a new solution of adding blue-light excited blue PersL phosphor to the original yellow PersL phosphor to generate white light emission during the dimming time is proposed. However, contrary to the steady advancement of research focusing on PersL phosphors in the yellow region, the research on blue PersL phosphors that can be used in AC-LEDs is still scarce. Therefore, it is critical to develop and synthesize outstanding blue PersL phosphors

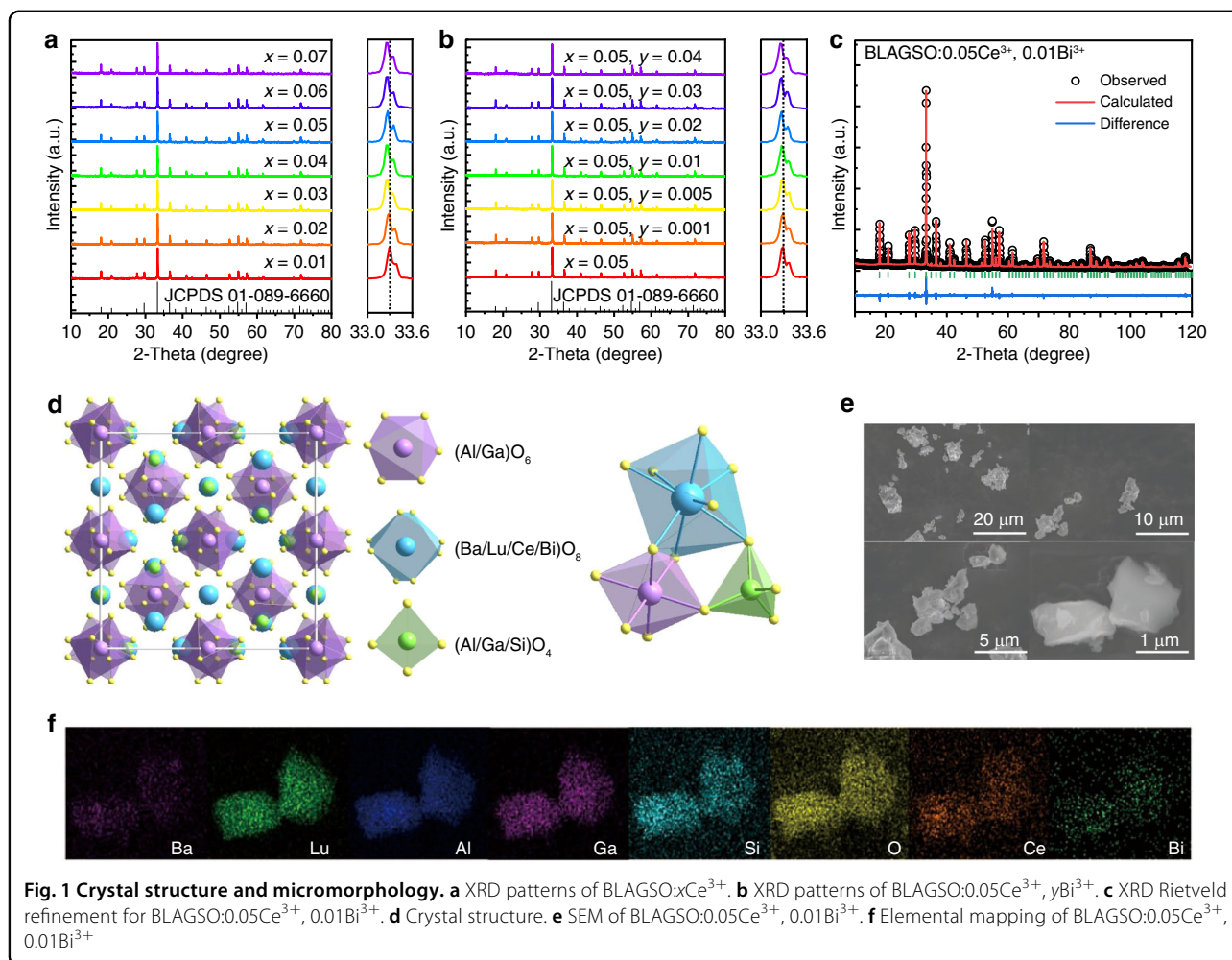
with high intensity, appropriate duration, and effective excitation by blue-light.

Herein, we synthesized a series of excellent blue-light excited cyan PersL phosphor by co-doping Bi^{3+} into Ce^{3+} activated $\text{BaLu}_2\text{Al}_2\text{Ga}_2\text{SiO}_{12}$. The phosphors exhibit cyan emission under 425 nm excitation, and intense cyan PersL can be observed after ceasing the excitation. Meanwhile, we found that co-doping Bi^{3+} not only effectively enhanced the PersL intensity, but also regulated the PersL lifetime of this phosphors. As the Bi^{3+} co-doping concentration increases to 0.01, the value of τ_{80} increases from 0.24 to 19.61 ms. Aiming to minimize the flicker effect and compensate for the absence of blue-light component during the dimming time in each AC cycle, an AC-LED lamp was fabricated using commercial orange-red PersL phosphor $\text{Sr}_{0.75}\text{Ca}_{0.25}\text{S}:\text{Eu}^{2+}$ (SCS:Eu²⁺) and as-prepared phosphor $\text{BaLu}_2\text{Al}_2\text{Ga}_2\text{SiO}_{12}:0.05\text{Ce}^{3+}$, 0.01Bi^{3+} on a commercial blue-emitting chip. The device exhibits intense white light when the current is set to 20 mA and shows bright white PersL emission during the dimming time with a decreased percent flicker of 48.15%, which is significantly better than the other currently reported AC-LED devices based on PersL phosphors. These results demonstrate that $\text{BaLu}_2\text{Al}_2\text{Ga}_2\text{SiO}_{12}:\text{Ce}^{3+}$, Bi^{3+} might be a promising blue-light excited cyan PersL phosphor for low-flicker AC-LEDs.

Results

Crystal structure and micromorphology

X-ray diffractometer (XRD) patterns of $\text{BaLu}_{2-x}\text{Al}_2\text{Ga}_2\text{SiO}_{12}:x\text{Ce}^{3+}$ (BLAGSO: $x\text{Ce}^{3+}$) and $\text{BaLu}_{1.95-y}\text{Al}_2\text{Ga}_2\text{SiO}_{12}:0.05\text{Ce}^{3+}, y\text{Bi}^{3+}$ (BLAGSO:0.05 Ce^{3+} , $y\text{Bi}^{3+}$) are exhibited in Fig. 1a, b, respectively. Clearly, there is a good correlation between the diffraction peaks and the $\text{Y}_3\text{Ga}_2\text{Al}_3\text{O}_{12}$ standard pattern (JCPDS 01-089-6660), confirming that pure phase was synthesized in all samples. With the augment of Ce^{3+} and Bi^{3+} concentrations, the magnified diffraction peak gradually shifts toward lower 2θ value side, which corresponds to the lattice expansion caused by Lu^{3+} (CN = 8, $r = 0.977 \text{ \AA}$) replaced by Ce^{3+} (CN = 8, $r = 1.143 \text{ \AA}$) and Bi^{3+} (CN = 8, $r = 1.17 \text{ \AA}$)²³. To further corroborate the phase purity, the Rietveld refinements for BLAGSO, BLAGSO:0.05 Ce^{3+} , and BLAGSO:0.05 Ce^{3+} , 0.01Bi^{3+} were carried out and the results are shown in Figs. S1 and 1c. The obtained R_{wp} and R_p converge to 6.03% and 4.50% for BLAGSO, 6.06% and 4.52% for BLAGSO:0.05 Ce^{3+} , 6.21% and 4.60% for BLAGSO:0.05 Ce^{3+} , 0.01Bi^{3+} , respectively, which implies that the refined results are highly credible. Tables S1–4 list the other detailed Rietveld refinement results. The as-prepared BLAGSO:0.05 Ce^{3+} , 0.01Bi^{3+} phosphor crystallizes in a cubic structure with space group $\text{Ia}\bar{3}\text{d}$ (230). The refined parameters for the lattice are $a = b = c = 12.0648 \text{ \AA}$, $V = 1756.137 \text{ \AA}^3$. In comparison to BLAGSO ($a = b = c = 12.0483 \text{ \AA}$, $V = 1748.952 \text{ \AA}^3$)



and BLAGSO: 0.05Ce^{3+} ($a = b = c = 12.0620 \text{ \AA}$, $V = 1754.924 \text{ \AA}^3$), the increased lattice parameters of BLAGSO: 0.05Ce^{3+} , 0.01Bi^{3+} also reveal that Bi^{3+} and Ce^{3+} successfully occupied the Lu^{3+} site. The crystal structure is shown in Fig. 1d, which demonstrates that the highly symmetrical crystal structure of BLAGSO: 0.05Ce^{3+} , 0.01Bi^{3+} contains three kinds of polyhedrons: $[(\text{Al}/\text{Ga}/\text{Si})\text{O}_4]$ tetrahedron, $[(\text{Al}/\text{Ga})\text{O}_6]$ octahedron, and $[(\text{Ba}/\text{Lu}/\text{Ce}/\text{Bi})\text{O}_8]$ dodecahedron. $[(\text{Al}/\text{Ga}/\text{Si})\text{O}_4]$ tetrahedrons and $[(\text{Al}/\text{Ga})\text{O}_6]$ octahedrons are linked by sharing O^{2-} points. They also share edges or corners with $[(\text{Ba}/\text{Lu}/\text{Ce}/\text{Bi})\text{O}_8]$ dodecahedrons to create a complex three-dimensional network.

Scanning electron microscope (SEM) images of BLAGSO: 0.05Ce^{3+} , 0.01Bi^{3+} are depicted in Fig. 1e, which exhibit irregular grain morphology and particle sizes. Figure 1f shows the elemental mapping images, which certify that all elements in the sample are homogeneously dispersed without any aggregation throughout the whole particle.

Electronic structure

Figure 2 exhibits the calculated results of BLAGSO: 0.05Ce^{3+} when considering the site-preference strategy for Bi^{3+} . The low doping concentration of Bi^{3+} in the host makes it challenging to determine site-preference in the experiment. First-principles calculations have been demonstrated to be reliable in determining the most likely location of Bi^{3+} substitution sites based on relative formation energies. After structural optimization, according to Eq. (1), Bi^{3+} is set to occupy the Lu^{3+} site with the lowest formation energy (-2.3143 eV) instead of the Ba^{3+} site with a higher formation energy (-1.2755 eV)²⁴. This result indicates that Bi^{3+} preferentially occupies the Lu^{3+} site.

$$E_f = E_{\text{total}} - n_{\text{Ba}}\mu_{\text{Ba}} - n_{\text{Lu}}\mu_{\text{Lu}} - n_{\text{Al}}\mu_{\text{Al}} - n_{\text{Ga}}\mu_{\text{Ga}} - n_{\text{Si}}\mu_{\text{Si}} - n_{\text{O}}\mu_{\text{O}} - n_{\text{Ce}}\mu_{\text{Ce}} - n_{\text{Bi}}\mu_{\text{Bi}} \quad (1)$$

where E_f is the formation energy, E_{total} reflects the total density functional theory (DFT) energy, μ refers to the

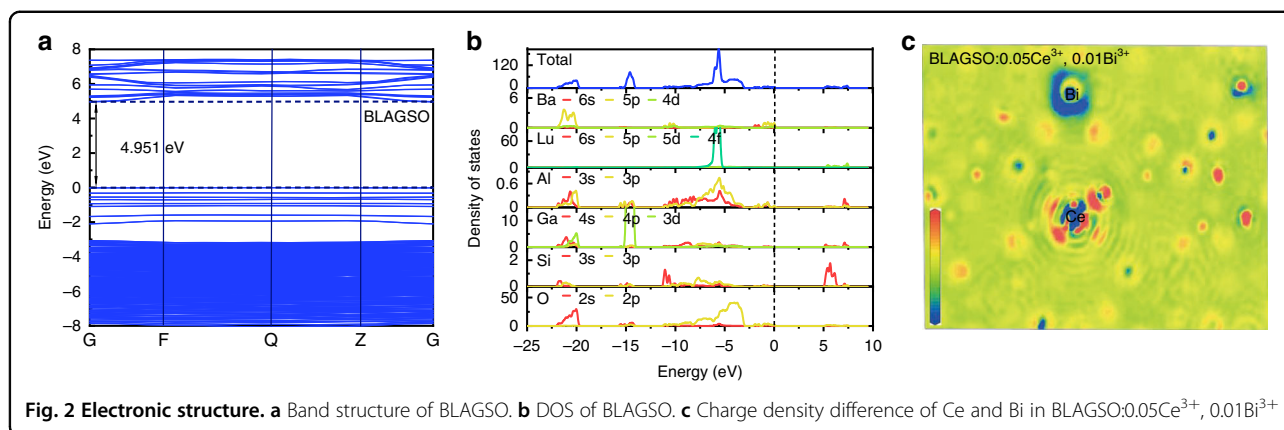


Fig. 2 Electronic structure. **a** Band structure of BLAGSO. **b** DOS of BLAGSO. **c** Charge density difference of Ce and Bi in BLAGSO:0.05Ce³⁺, 0.01Bi³⁺

atomic chemical potentials, and n means the atomic quantities.

The band structure of the host BLAGSO calculated using the generalized gradient approximation (GGA)-Perdew-Burke-Ernzerhof (PBE) formula is shown in Fig. 2a. Obviously, BLAGSO possesses a direct bandgap (E_g) about 4.951 eV, since the maximum of valence band and the minimum of CB are placed at the G point. The discrepancy between experimental and calculated values is mainly due to the inherent shortcomings of the DFT-PBE methods. Partial density of state (DOS) can be used to further analyze the composition of the calculated band structure, as presented in Fig. 2b. The low-energy area around the Fermi level is mainly contributed by Ba-5p, Lu-4f, Ga-3d, O-2s2p states, while Lu-5d, Ga-4s, Si-3s3p states mainly dominate the CB. According to the DOS analysis, O-2p states play a critical part in the area surrounding the Fermi level because of the strong electronegativity of the O ion, and the Lu-O bond is formed by hybridization of O-2p with Lu-4f, which determines the optical properties of BLAGSO. Charge sharing and distribution can be predicted using charge density difference and bader charge. The charge density difference provides a visual picture of the change in charge distribution involving the introduction of Ce³⁺ and Bi³⁺ into BLAGSO (Fig. 2c). Here, the red color (positive) around the Ce atom indicates that Ce³⁺ loses electrons, while the blue color (negative) around the Bi atom indicates that Bi³⁺ gains electrons. Moreover, the bader charge of Bi is -2.03 eV in BLAGSO:0.05Ce³⁺, 0.01Bi³⁺, which is similar to the bader charge of -1.97 eV in BiO. Therefore, the above results confirm the presence of Bi²⁺, which also provides a basis for Bi³⁺ to act as electron trapping centers in BLAGSO:Ce³⁺, Bi³⁺.

Luminescence properties

The diffuse reflectance (DR) spectra of BLAGSO, BLAGSO:0.05Ce³⁺, and BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ are presented in Fig. 3a. The undoped BLAGSO sample

exhibits strong absorption located at 200–350 nm and high reflection between 350 and 800 nm. In the case of Ce³⁺ doped or Ce³⁺/Bi³⁺ co-doped BLAGSO, strong absorption bands appear at 200–500 nm, which are ascribed to Ce³⁺: 4f → 5d transition. The host experimental E_g was calculated based on the following equations²⁵:

$$[F(R)hv]^2 = C(hv - E_g) \quad (2)$$

$$[F(R)] = (1 - R)^2/2R \quad (3)$$

where hv means the photon energy, R denotes reflectance coefficient, C is an absorption constant, and E_g represents the experimental bandgap. As presented in the inset of Fig. 3a, the experimental E_g is 5.78 eV.

Figure 3b shows the photoluminescence excitation (PLE) and photoluminescence emission (PL) spectra of BLAGSO:0.05Ce³⁺. The PLE spectrum consists of an intense excitation band between 390 and 470 nm peaking around 425 nm and a weak excitation band between 340 and 380 nm peaking at 360 nm, which originate from Ce³⁺: 4f → 5d₁ and 4f → 5d₂ transitions. BLAGSO:0.05Ce³⁺ exhibits a luminescence band within the 450–650 nm spectral region centered at 485 nm under 425 nm excitation, belonging to the Ce³⁺: 5d → 4f transition. As we all know, host lattice strongly influences Ce³⁺ emission. According to recent reports, replacing Lu³⁺-Al³⁺ with Ba²⁺-Si⁴⁺ in Lu₃Al₅O₁₂:Ce³⁺ has the effect of reducing Stokes shift and causing a blue-shift in PL spectrum²⁶. In addition, a reduction in crystal field splitting takes place due to the increased diameter of the ions substituted at the octahedral sites. Partial substitution of Al³⁺ with Ga³⁺ also causes a blue-shift in PLE and PL spectra. Because of the extremely symmetrical crystal structure of BLAGSO, the Stokes shift of Ce³⁺ emission is relatively small (2910 cm⁻¹, 0.36 eV), making the realization of blue-light stimulated cyan-emitting PersL phosphor possible. Furthermore, the emission peak can be deconvoluted to two Gaussian peaks

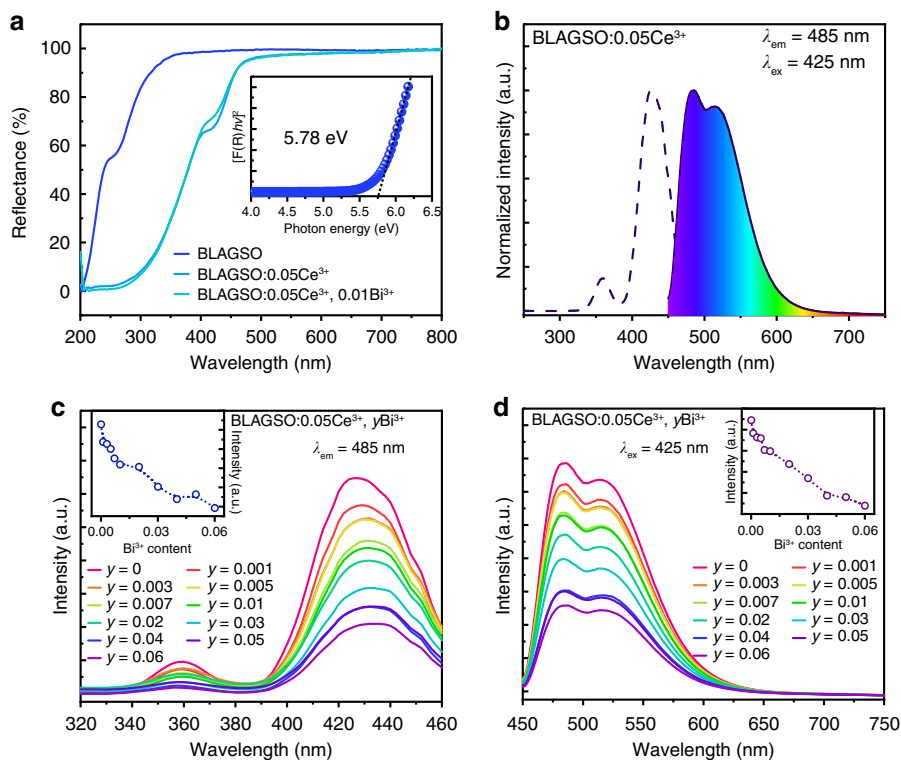
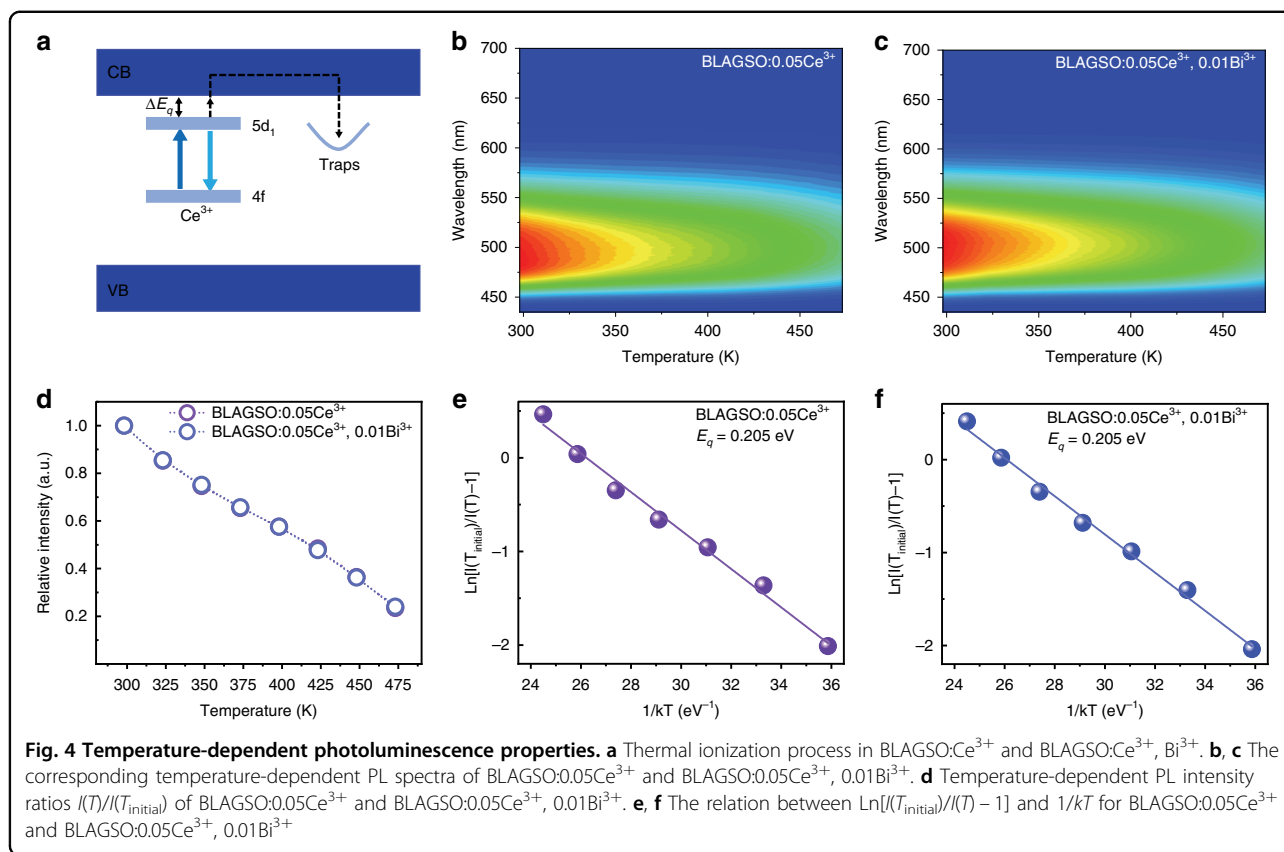


Fig. 3 Photoluminescence properties. **a** DR spectra of BLAGSO, BLAGSO:0.05Ce³⁺, and BLAGSO:0.05Ce³⁺, 0.01Bi³⁺. Inset: the experimental E_g of BLAGSO. **b** PLE and PL spectra of BLAGSO:0.05Ce³⁺. **c** PLE spectra of BLAGSO:0.05Ce³⁺, y Bi³⁺. Inset: the PLE intensity of BLAGSO:0.05Ce³⁺, y Bi³⁺. **d** PL spectra of BLAGSO:0.05Ce³⁺, y Bi³⁺. Inset: the PL intensity of BLAGSO:0.05Ce³⁺, y Bi³⁺.

at 20,872 and 19,257 cm^{-1} with an energy difference of 1615 cm^{-1} , as shown in Fig. S2, corresponding to the theoretical energy separation between the $^2F_{5/2}$ and $^2F_{7/2}$ levels of Ce^{3+} ^{27,28}. Figure 3c, d depicts the PLE and PL spectra of BLAGSO:0.05Ce³⁺, y Bi³⁺. As the co-doping content of Bi³⁺ increases, the PL intensity of Ce³⁺ gradually declines under 425 nm excitation. It may be closely connected with the trapping of the excited 5d electrons of Ce³⁺. The trapped electrons cannot escape immediately resulting in the reduction of emission intensity. The internal quantum efficiencies (IQEs) of BLAGSO:0.05Ce³⁺ and BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ are 92.2% and 48.6%, respectively (Fig. S3). Meanwhile the PLE and PL spectra of BLAGSO:0.05Ce³⁺, y Bi³⁺ have same shapes as those of BLAGSO:0.05Ce³⁺, indicating that the Ce³⁺ is the emission center in both Bi³⁺ doped and undoped samples, and there is no energy transfer between Ce³⁺ and Bi³⁺, which can be further demonstrated by the PLE and PL spectra of BLAGSO:0.01Bi³⁺ (Fig. S4).

The $d \rightarrow f$ transition of Ce³⁺ is often accompanied by some non-radiative processes, such as thermal ionization and non-radiative crossover relaxation. Since the thermal ionization process is usually related to the charging process of PersL, the energy gap between the bottom of

CB and the lowest Ce³⁺: 5d₁ level is crucial for the PersL generation. It is actually the case that many Eu²⁺-doped phosphors exhibit thermal quenching caused by thermal ionization rather than crossover mechanism²⁹. This quenching mechanism also applies to Ce³⁺, as illustrated in Fig. 4a³⁰. In the case of thermal ionization causing the quenching process, the energy gap between CB and 5d₁ level may be determined by analyzing and studying the temperature dependence of non-radiative decay rates. Due to the relatively small Stokes shift of BLAGSO:Ce³⁺ and BLAGSO:Ce³⁺, Bi³⁺, we can assume that the non-radiative 5d \rightarrow 4f crossover relaxation has less effect on the thermal quenching. Thus, this approach can be used to evaluate the role of thermal ionization process of Ce³⁺ excited 5d electrons into CB for BLAGSO:Ce³⁺ and BLAGSO:Ce³⁺, Bi³⁺ in the PersL charging process. Figures 4b, c and S5 exhibit the temperature-dependent PL spectra of BLAGSO:0.05Ce³⁺ and BLAGSO:0.05Ce³⁺, 0.01Bi³⁺, respectively. Figure 4d shows the corresponding normalized PL spectra. One can see that the quenching process is strongly influenced by temperature and the temperature-dependence of the non-radiative decay rate is approximately the same for both samples. The energy barrier can be accurately modeled using the single barrier



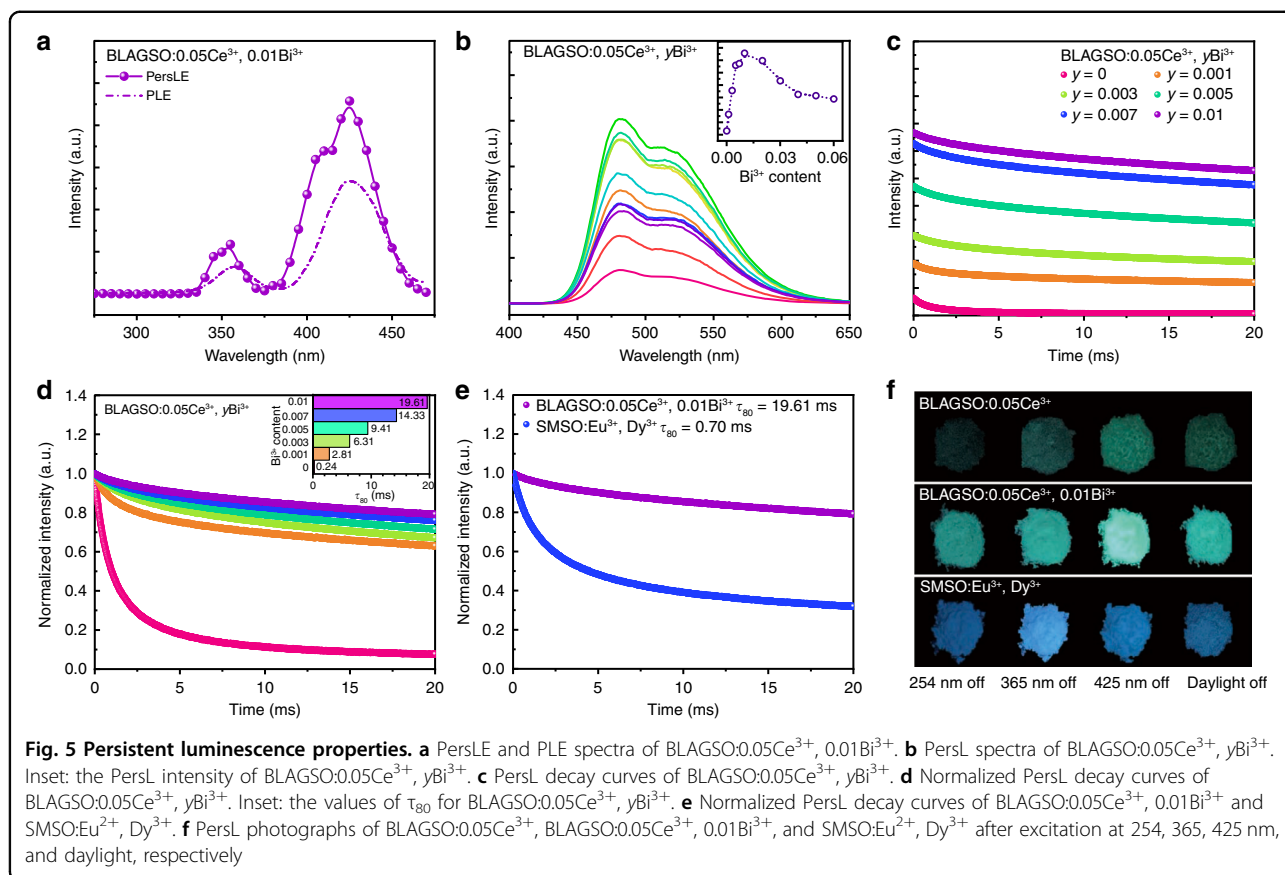
quenching function^{31,32}:

$$I(T) = \frac{I(T_{\text{initial}})}{1 + \frac{\Gamma_0}{\Gamma_v} \exp(-E_q/kT)} \quad (4)$$

where $I(T_{\text{initial}})$ donates the initial luminescence intensity and $I(T)$ is the intensity at temperature T , Γ_0 refers to the attempt rate for the thermal ionization process and Γ_v represents the radiative decay rate, k is Boltzmann constant, E_q refers to the energy barrier for thermal ionization of Ce³⁺ emission. As presented in Fig. 4e, f, the E_q of BLAGSO:0.05Ce³⁺ and BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ samples are estimated to be 0.205 eV. According to the results, co-doping Bi³⁺ has little effect on the distance between CB and Ce³⁺: 5d₁ level, in other words, the possibility of Ce³⁺: excited 5d electrons entering the CB by thermal ionization is the same. Based on the above analysis, we find that the reason for the enhancement of PersL by co-doping Bi³⁺ may be closely related to the electron capture during charging process, and the explanation is mentioned in the next section. Obviously, the energy gap between CB and 5d₁ level is about 0.205 eV, which is a suitable distance. First, due to its small energy gap, the excited 5d electrons are efficiently ionized into CB under blue-light excitation, as we expected, this phosphor can be charged by blue-light at

RT, making it promising for AC-LED applications. Second, the energy gap is sufficient for recombination luminescence due to incomplete quenching at RT.

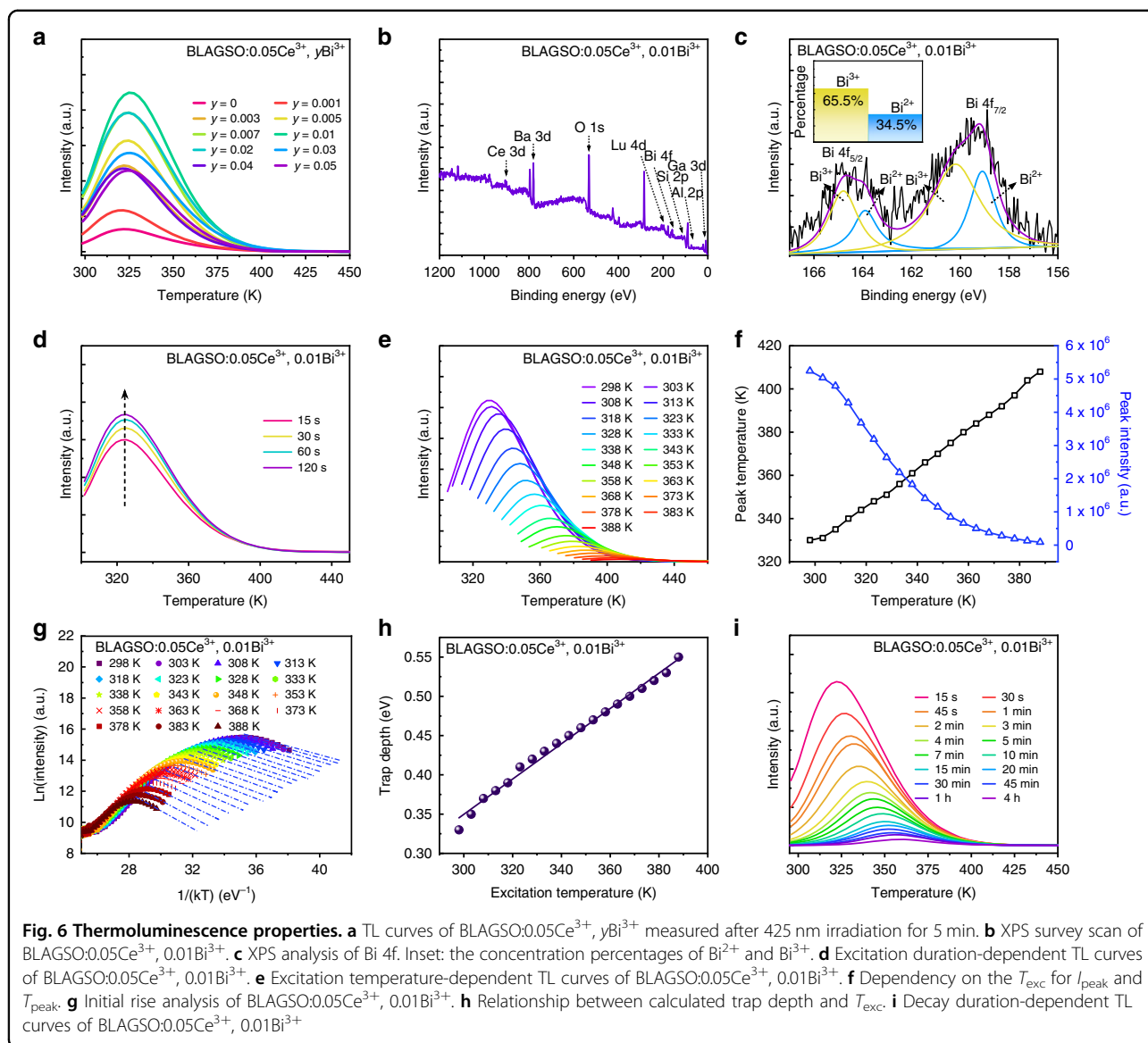
Garnet generated via high-temperature solid-state reaction generally exists plenty of localized defects, making garnet a potential candidate for PersL materials^{20,33}. That is one reason why we chose the highly coordinated silicate-containing garnet BLAGSO:0.05Ce³⁺ for the study of AC-LEDs. To date, most blue PersL phosphors need to be effectively activated under ultraviolet or X-ray irradiation³⁴. In this work, we find that BLAGSO:0.05Ce³⁺ exhibits weak PersL after ceasing the 425 nm blue-light irradiation, which concurs with the report of Lai et al, and remarkably, contrary to reducing the PL intensity, the Bi³⁺ co-doping significantly enhanced the PersL intensity of BLAGSO:0.05Ce³⁺³⁵. The PersL excitation (PersLE) spectrum of BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ shown in Fig. 5a, which was obtained by plotting PersL intensity versus excitation wavelength (Fig. S6a presents the representative PersL decay curves monitored at various excitation wavelengths), implies that BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ can be successfully stimulated by blue-light. Meanwhile, the spectral patterns of PLE and PersLE are analogous, indicating that the charging process of PersL originates from Ce³⁺: 4f → 5d excitation, and the thermal ionization of Ce³⁺: 5d



electrons into CB at RT is a crucial factor in the charging process as discussed above. The PersL spectra of BLAGSO:0.05Ce³⁺, yBi³⁺ samples were recorded and exhibited in Fig. 5b to evaluate the effect of Bi³⁺ on the PersL performance. Obviously, the shapes of both PersL and PL spectra are found to be similar, demonstrating the origination of PersL is also from 5d → 4f transition of Ce³⁺. As Bi³⁺ co-doping concentration increases, the PersL intensity raises first until 0.01 and then declines. The rise in PersL intensity may be caused by the release of more captured electrons to the 5d₁ level, while the quenching phenomenon related to the Bi³⁺ co-doping concentration is owing to the strengthened interaction of adjacent traps. This interaction can be interpreted by electron tunneling among traps at high Bi³⁺ concentrations³⁶. Figure 5c exhibits the PersL decay curves of BLAGSO:0.05Ce³⁺, yBi³⁺ within 20 ms after ceasing the 425 nm excitation, and their initial intensity corresponds to the PersL intensity. The normalized PersL decay curves are depicted in Fig. 5d, from which it can be seen that co-doping Bi³⁺ can regulate the PersL lifetime of this phosphors. The value of τ_{80} increases from 0.24 to 19.61 ms as the Bi³⁺ co-doping concentration increases to 0.01. Clearly, the τ_{80} value of BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ is large enough to meet the requirement of AC-LEDs for

dimming time⁹. When compared with the best known blue-emitting PersL phosphor Sr₂MgSi₂O₇:Eu²⁺, Dy³⁺ (SMSO:Eu²⁺, Dy³⁺), BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ exhibits stronger PersL intensity and superior PersL duration after 425 nm blue-light irradiation, and the τ_{80} value of BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ is far larger than that of SMSO:Eu²⁺, Dy³⁺ (about 0.70 ms), as presented in Figs. 5e and S6b³⁷. Figure 5f shows the PersL photographs of BLAGSO:0.05Ce³⁺, BLAGSO:0.05Ce³⁺, 0.01Bi³⁺, and SMSO:Eu²⁺, Dy³⁺ after excitation at 254, 365, 425 nm, and daylight, respectively. We can clearly see that the PersL intensity of BLAGSO:0.05Ce³⁺ is significantly enhanced by co-doping Bi³⁺, and the best excitation band for the PersL of SMSO:Eu²⁺, Dy³⁺ is located in the ultraviolet region, which makes it difficult to be applied in the field of AC-LEDs based on blue chips.

To better understand the mechanism of PersL in BLAGSO:Ce³⁺, Bi³⁺, the trap charging and detrapping processes were comprehensively investigated by a series of thermoluminescence (TL) measurements. The TL technique is the most effective method to study trap properties, such as trap distribution, depth, and density, as well as the interaction between electron trapping centers and emission centers in PersL phosphors. Figure 6a depicts the Bi³⁺ concentration-dependent TL spectra. The distribution of



TL bands correlates with the trap depth, and the TL peaks mainly locate in the low-temperature region revealing the shallow depth of most traps. As can be seen, when the Bi³⁺ co-doping concentration is 0.01, the TL intensity reaches its maximum and subsequently drops as the concentration rises. Also noteworthy, the position and intensity of TL peak are strongly influenced by Bi³⁺ concentration, suggesting that the doping of Bi³⁺ promotes trap creation and affects trap concentration. According to Dorenbos et al., Bi³⁺ can act as both electron traps to form Bi²⁺ and hole traps to form Bi⁴⁺, and considering the previous discussion on the charge density difference, bader charge, and thermal ionization process of Ce³⁺, we tend to think that Bi³⁺ ions serve as electron trapping centers in BLAGSO:Ce³⁺, Bi³⁺ phosphors^{38,39}. To further confirm this mechanism, the existence of Bi²⁺

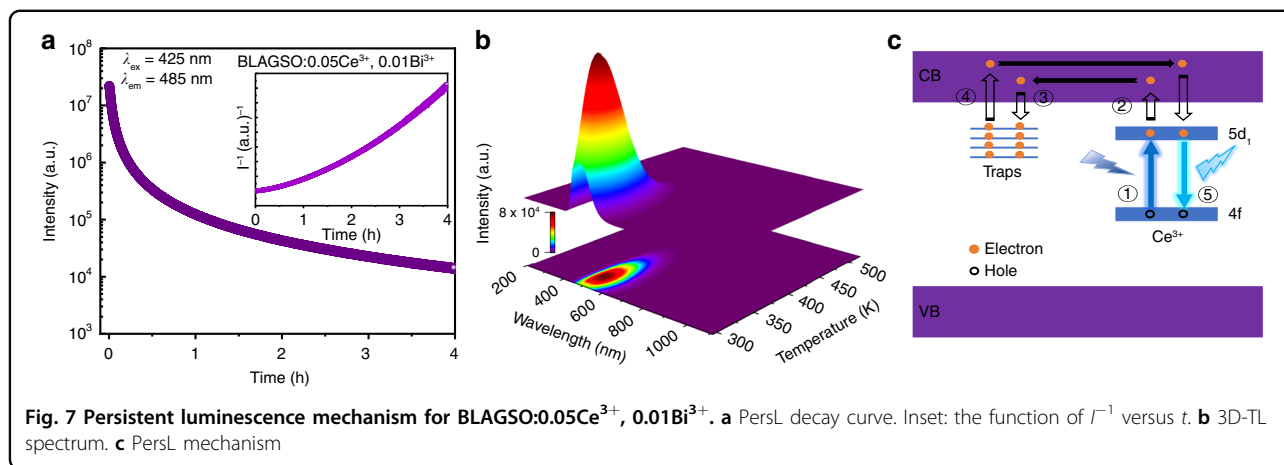
was confirmed using X-ray photoelectron spectroscopy (XPS) investigation. Figure 6b illustrates the XPS survey scan of BLAGSO:0.05Ce³⁺, 0.01Bi³⁺, where all elements can be observed. The corresponding high-resolution Bi 4f XPS scan exhibits two binding energy peaks corresponding to the Bi 4f_{5/2} and 4f_{7/2}, respectively. As shown in Fig. 6c, after deconvolution, the peaks at 160.2 eV, 164.8 eV are attributed to Bi³⁺, while the peaks at 159.1 eV, 163.9 eV are attributed to Bi²⁺, and the ratios of Bi³⁺ and Bi²⁺ components are about 65.5% and 34.5%, respectively^{40–42}. Accordingly, we confirm the presence of Bi in the mixed oxidation state, and further verify the role of Bi³⁺ acting as the electron trapping centers in the BLAGSO:Ce³⁺, Bi³⁺ phosphors. Moreover, oxygen vacancie V_O may be generated during the sintering process, which also contributes to the occurrence of PersL⁴³.

A sequence of irradiation duration-dependent TL tests was carried out on BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ and the results are demonstrated in Fig. 6d. The TL intensity enhances as the excitation time increases since more electrons are trapped. The positions of all the TL peaks present no appreciable shift for different exposure time. This demonstrates that the electron escaping from traps conforms to first-order kinetic, which means that every electron released from the traps immediately recombines with the emission center to produce luminescence without being recaptured by the traps⁴⁴. The first-order TL curves generally exhibit asymmetric glow peaks with negative slope, however, the curve profiles shown in Fig. 6d are approximately symmetric and relatively wide, suggesting the possibility of an overlap of various peaks with close trap depth distributions⁴⁵. To further investigate the trap depth, we carried out a sequence of excitation temperature (T_{exc})-dependent TL analysis on BLAGSO:0.05Ce³⁺, 0.01Bi³⁺, as illustrated in Fig. 6e⁴⁶. These analyses were conducted in accordance with the Eeckhout's method. Each measurement involved heating the sample to a specified T_{exc} , excited by 425 nm blue-light for 3 min, and stabilized for 3 min before starting measurements at 3 K s⁻¹ rising rate from T_{exc} . Stabilizing keeps the traps from being affected by the unstable electrons and the rapid decay process. Thus, the trap properties obtained by TL curves reveal the state of traps occupied by stable electrons under the different T_{exc} . The plot of TL peak intensity (I_{peak}) and TL peak temperature (T_{peak}) versus T_{exc} is shown in Fig. 6f. The TL intensity reduces with rising T_{exc} , along with the TL peak position shifts toward higher temperatures, mainly due to the thermal depletion of electrons. Since TL peak temperature reflects trap depth, TL peak shift in BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ implies a continuous trap distribution. An initial rising method on the TL curves shown in Fig. 6g is used to further estimated trap depth. According to this method, the trapped electron

concentrations are assumed to remain constant on low-temperature side, and thus, the TL intensity ($I(T)$) is unaffected by kinetics. This can be evaluated by the following formula^{46,47}:

$$I(T) = C \exp\left(\frac{-E}{kT}\right) \quad (5)$$

where E represents the trap depth, k denotes the Boltzmann constant, and C is the pre-exponential constant. E can be calculated from TL curves by plotting $\ln(I)$ and $1/T$. Clearly, as T_{exc} increases, the trap depths range between 0.30 and 0.56 eV. As we all know, trap depths of 0.2–0.5 eV are well suited for the generation of PersL. The trap depth in BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ sample is highly compatible with ideal trap depth of PersL phosphors that can be applied in the field of AC-LEDs²⁹. By further depicting the relationship between T_{exc} and estimated trap depth, the distribution of trap depth can be approximately determined, as shown in Fig. 6h. One can see that it follows a linear fit, indicating a constant detrapping rate, on the basis of which we can conclude that BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ has a uniform trap depth distribution. Figure 6i exhibits the TL curves of BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ measured at different decay durations after 425 nm blue-light excitation, and the change of TL curve profiles shows the electron detrapping process. As we can see, as decay time rises, TL peaks move to the higher temperature side. That means the electrons first escape from the shallow traps, followed by the slow release of electrons stored in deep traps. To clearly reveal the electron detrapping of PersL, Fig. 7a presents PersL decay curve of BLAGSO:0.05Ce³⁺, 0.01Bi³⁺. Apparently, in the beginning, the PersL intensity drops rapidly, then it slowly declines for several hours. Further, the inset of Fig. 7a exhibits the correlation between reciprocal PersL intensity (I^{-1}) and time (t) converted from the PersL decay curve. The $I^{-1}-t$ curve



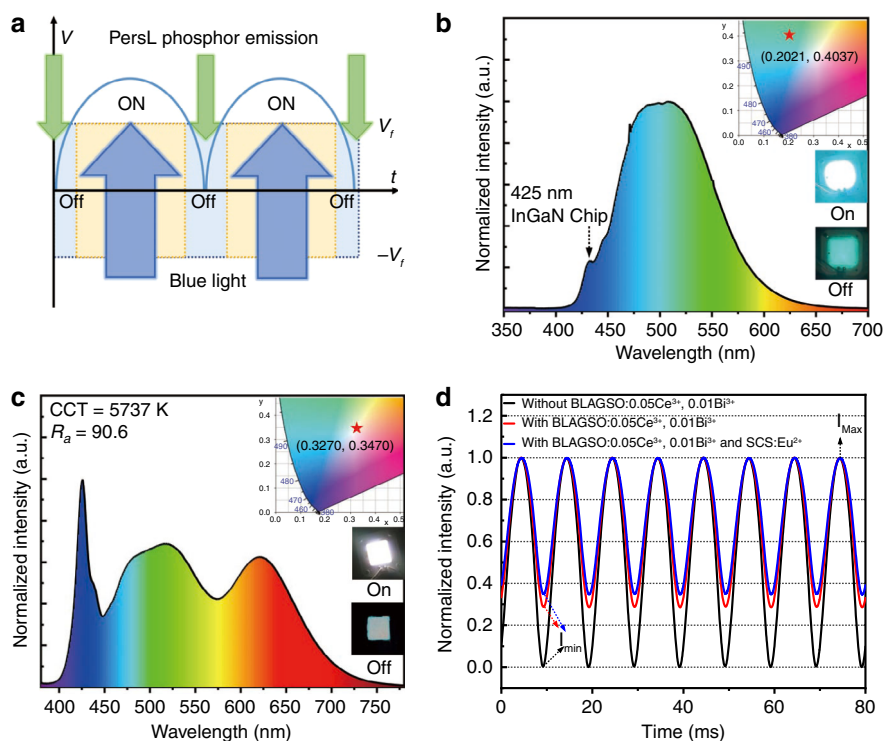


Fig. 8 AC-LED applications for BLAGSO:Ce³⁺, Bi³⁺. **a** The scheme of AC flicker compensation using PersL phosphors. **b** EL spectrum of BLAGSO:0.05Ce³⁺, 0.01Bi³⁺. Inset: the CIE chromaticity coordinate and AC-LED device images on and off states. **c** EL spectrum of the white AC-LED fabricated by commercial orange-red PersL phosphor SCS:Eu²⁺, as-prepared phosphor BLAGSO:0.05Ce³⁺, 0.01Bi³⁺, and a 425 nm InGaN chip. Inset: the CIE chromaticity coordinate and AC-LED device images on and off states. **d** Luminescence intensity variation during AC cycle

deviates from a straight line, indicating that the electron detrapping process is due to thermal detrapping of electrons from traps into CB⁴⁸. Figure 7b depicts the 3D-TL spectrum of BLAGSO:0.05Ce³⁺, 0.01Bi³⁺. From this spectrum, TL curves at various wavelengths and TL emission at various temperatures can be observed. Obviously, the TL emission of BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ at different temperatures has a similar shape and position to the PersL emission.

On the basis of above results and analysis, we put forward a reasonable mechanism illustrated in Fig. 7c to explain the generation of the blue-light excited cyan PersL from BLAGSO:Ce³⁺, Bi³⁺ phosphor, which mainly consists of the following processes: ① excitation, ② electron ionization, ③ electron trapping, ④ electron detrapping, ⑤ electron recombination¹⁷. Electrons are stimulated from Ce³⁺: 4f ground state to 5d₁ state when exposed to 425 nm blue-light during charging process. In view of the relatively small energy gap between CB and 5d₁ level, plenty of excited electrons are easily thermally ionized from the 5d₁ level to CB and subsequently captured by traps via CB. Bi³⁺ ions and V_O can capture the escaping electrons, which serve as the electron trapping centers, and the holes are formed in the Ce³⁺: 4f ground state. The detrapping process involves releasing the

trapped electrons to 5d₁ level via CB after stopping the irradiation, and these electrons finally recombine with the holes in Ce³⁺, resulting in the occurrence of bright cyan PersL. The Bi³⁺ co-doping significantly enhanced both intensity and duration of PersL in Ce³⁺-doped BLAGSO phosphors, making it a potential candidate for AC-LED applications.

Application of BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ in AC-LEDs

For the purpose of evaluating the effectiveness of this PersL phosphor in reducing the flicker effect, we fabricated an AC-LED device by combining a 425 nm blue-emitting chip with BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ based phosphor-in-silicone (PiS). Figure 8a exhibits the AC flicker compensation scheme using PersL phosphors. BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ phosphor is excited to generate cyan-light at a voltage higher than V_f , meanwhile, there are many electrons stored in the traps. When the excitation stops at a voltage lower than V_f , the trapped electrons are released to produce PersL and the flicker effect of AC-LEDs is compensated. The corresponding electroluminescence (EL) spectrum is presented in Fig. 8b. Under a current of 20 mA, the device displays cyan emission with a CIE coordinate of (0.2021, 0.4037). Figure 8d shows the EL intensity variation at each AC cycle for

the AC-LEDs with and without BLAGSO:0.05Ce³⁺, 0.01Bi³⁺. The flicker effect is usually expressed as the percent flicker (δ), which can be obtained according to the following formula²¹:

$$\delta = \frac{I_{\max} - I_{\min}}{I_{\max} + I_{\min}} \quad (6)$$

where I_{\max} and I_{\min} represent the maximum and minimum values of the luminous intensity, respectively. Obviously, the percent flicker of AC-LED is reduced from 100% to 55.04% owing to the compensation of PersL.

To further demonstrate that our solution of adding blue-light excited blue PersL phosphor to the original yellow PersL phosphor to generate white emission during the dimming time is reliable, we fabricated a white AC-LED device by using orange-red PersL phosphor SCS:Eu²⁺ and as-prepared phosphor BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ on a 425 nm blue-emitting chip. As shown in Fig. 8c, the lamp displays bright white light with a CIE coordinate of (0.3270, 0.3470), the color render index (R_a) of 90.6, and a correlated color temperature (CCT) of 5737 K under a current of 20 mA. It exhibits bright white PersL emission during the dimming time, and its percent flicker is reduced to 48.15% as presented in Fig. 8d. These results indicate that the cyan PersL phosphor BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ has great potential for AC-LED applications.

Discussion

In conclusion, we synthesized a sequence of excellent blue-light excited cyan-emitting PersL phosphors by introduced Bi³⁺ into BaLu₂Al₂Ga₂SiO₁₂:Ce³⁺. Benefiting from the highly symmetric crystal structure of BLAGSO, the phosphors show a relatively small Stokes shift of 0.36 eV. With a suitable energy gap between CB and Ce³⁺:5d₁ level, phosphor can be efficiently charged under 425 nm blue-light at RT. The co-doping of Bi³⁺ ions has little influence on the mechanisms of both PL and PersL, but can dramatically optimize the PersL lifetime. The τ_{80} value of BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ is 19.61 ms, which proves to be effective in compensating the flicker effect of AC-LEDs. Based on the unique PersL properties of the phosphors, a new method of generating white light emission during the dimming time through adding blue-light excited blue PersL phosphor to the original yellow PersL phosphor was proposed, and an AC-LED lamp was fabricated using orange-red PersL phosphor SCS:Eu²⁺ and as-prepared phosphor BLAGSO:0.05Ce³⁺, 0.01Bi³⁺ on a 425 nm blue-emitting chip, the percent flicker of which was reduced from 100% to 48.15%. These results demonstrate that BLAGSO:Ce³⁺, Bi³⁺ might be a promising material for low-flicker AC-LEDs with the remarkable benefits of more compact volume, cheaper

manufacturing cost, greater energy usage efficiency, and longer service life.

Materials and methods

Materials and preparation

A sequence of BLAGSO:*x*Ce³⁺ and BLAGSO:0.05Ce³⁺, *y*Bi³⁺ were produced via traditional high-temperature solid-state reaction. The starting ingredients included Bi₂O₃ (99.999%), Ce₂(CO₃)₃ (99.999%), SiO₂ (A.R.), Ga₂O₃ (99.99%), Al₂O₃ (99.99%), Lu₂O₃ (99.99%), BaF₂ (A.R.), and BaCO₃ (A.R.). Following the weighing of the starting ingredients based on the stoichiometric proportions, we mixed and ground the ingredients for 20 min in agate mortars. The resulting mixture was transferred to alumina crucibles and heated at 1400 °C for 5 h under N₂ environment. After being cooled to RT, the synthesized sample was ground again for further characterization.

According to Hai et al.⁴⁹, the phosphor SMSO:Eu²⁺, Dy³⁺ was produced via a high-temperature solid-state process. The raw materials including Dy₂O₃ (99.999%), Eu₂O₃ (99.999%), SiO₂ (A.R.), MgO (A.R.), SrCO₃ (A.R.), and H₃BO₃ (A.R.) were weighed according to the stoichiometric proportions. After being thoroughly mixed for 20 min in agate mortars, the mixture was placed in alumina crucibles and heated at 1250 °C for 5 h under 5%H₂/95%N₂ environment. After being cooled to RT, the synthesized sample was ground again for further characterization.

Characterization

XRD patterns were recorded using a Bruker D8 focus diffractometer. The morphology and elemental mapping were obtained by a scanning electron microscope (SEM, S-4800, Hitachi). The DR spectra were measured using a UV-vis-NIR spectrophotometer (Shimadzu, Japan). The PLE and PL spectra were obtained using a Hitachi F-7000 spectrophotometer. This spectrophotometer was also used to obtain the PersL spectra, the PersLE spectrum, and the PersL decay curves. Temperature-dependent PL spectra were collected on the Edinburgh Instruments FLS 920 spectrophotometer. IQEs were acquired using a Photonic Multi-channel Analyzer C10027 (Hamamatsu, Japan). The PersL digital photographs were recorded on a Canon EOS 600D. The homemade instrument composed of a heating device and a CCD detector was used to obtain TL spectra. XPS was carried out on a VG ESCALABMK II electron spectrometer. The EL performance was obtained using Starspec SSP6612 apparatus. The light flicker analyzer (Everfine Photo-E-Info Co. Ltd, LFA-3000) was used to assess the percent flicker of the AC-LEDs.

AC-LED fabrication

Each AC-LED device was manufactured by combining a PiS made by dispersing the prepared phosphors in

silicone with a 425 nm blue-emitting chip. The final AC-LED device was formed by curing the packaged device at 150 °C for 8 h.

Acknowledgements

The research is financially supported by the National Key R&D Program of China (Grant No. 2019YFA0709101), the R&D Projects in Key Areas of Guangdong Province (Grant No. 2020B0101010001), the National Natural Science Foundation of China (Grant No. 52072364, 51902305, 22175169). Thanks to eceshi (www.eceshi.com) for the DFT calculation analysis.

Author details

¹State Key Laboratory of Rare Earth Resource Utilization, Changchun Institute of Applied Chemistry, Chinese Academy of Sciences, Changchun 130022, China. ²University of Science and Technology of China, Hefei 230026, China. ³Zhongke Rare Earth (Guangzhou) Co., Ltd, Guangzhou 510700, China

Conflict of interest

The authors declare no competing interests.

Supplementary information The online version contains supplementary material available at <https://doi.org/10.1038/s41377-022-00868-8>.

Received: 19 February 2022 Revised: 10 May 2022 Accepted: 28 May 2022
Published online: 17 June 2022

References

- Reineke, S. Complementary LED technologies. *Nat. Mater.* **14**, 459–462 (2015).
- Zhao, M. et al. Emerging ultra-narrow-band cyan-emitting phosphor for white LEDs with enhanced color rendition. *Light: Sci. Appl.* **8**, 38 (2019).
- Yen, H. H., Yeh, W. Y. & Kuo, H. C. GaN alternating current light-emitting device. *Phys. Status Solidi (A)* **204**, 2077–2081 (2007).
- Liu, P. et al. Enhanced luminescence and afterglow by heat-treatment in reducing atmosphere to synthesize the $\text{Gd}_3\text{Al}_2\text{Ga}_3\text{O}_{12}:\text{Ce}^{3+}$ persistent phosphor for AC-LEDs. *J. Alloy. Compd.* **731**, 389–396 (2018).
- Lin, H. et al. Phosphor-in-glass for high-powered remote-type white AC-LED. *ACS Appl. Mater. Interfaces* **6**, 21264–21269 (2014).
- Chen, L. et al. A new green phosphor of $\text{SrAl}_2\text{O}_4:\text{Eu}^{2+}, \text{Ce}^{3+}, \text{Li}^+$ for alternating current driven light-emitting diodes. *Mater. Res. Bull.* **47**, 4071–4075 (2012).
- Zhang, R. et al. A new-generation color converter for high-power white LED: transparent Ce^{3+} : YAG phosphor-in-glass. *Laser Photonics Rev.* **8**, 158–164 (2014).
- Zhang, X. J. et al. Highly thermally stable single-component white-emitting silicate glass for organic-resin-free white-light-emitting diodes. *ACS Appl. Mater. Interfaces* **6**, 2709–2717 (2014).
- Tan, J. C. & Narendran, N. Defining phosphor luminescence property requirements for white AC LED flicker reduction. *J. Lumin.* **167**, 21–26 (2015).
- Li, X. S. & Zhao, L. T. UV or blue light excited red persistent perovskite phosphor with millisecond lifetime for use in AC-LEDs. *Luminescence* **35**, 138–143 (2020).
- Korte, S., Lindfeld, E. & Jüstel, T. Flicker reduction of AC LEDs by Mn^{2+} doped apatite phosphor. *ECS J. Solid State Sci. Technol.* **7**, R21–R26 (2018).
- Garner, R. Perspective—LED flicker. *ECS J. Solid State Sci. Technol.* **9**, 016017 (2020).
- Yang, Y. M. et al. X-ray-activated long persistent phosphors featuring strong UVC afterglow emissions. *Light: Sci. Appl.* **7**, 88 (2018).
- Pan, Z. W., Lu, Y. Y. & Liu, F. Sunlight-activated long-persistent luminescence in the near-infrared from Cr^{3+} -doped zinc gallogermanates. *Nat. Mater.* **11**, 58–63 (2012).
- Li, B. W. et al. Effects of SrCl_2 as a flux on the structural and luminescent properties of $\text{SrAl}_2\text{O}_4:\text{Eu}^{2+}, \text{Dy}^{3+}$ phosphors for AC-LEDs. *J. Alloy. Compd.* **651**, 497–502 (2015).
- Li, B. W. et al. Optical properties of $\text{SrAl}_{2-x}\text{Si}_x\text{O}_{4-x}\text{N}_x:\text{Eu}^{2+}, \text{Dy}^{3+}$ phosphors for AC-LEDs. *J. Alloy. Compd.* **679**, 436–441 (2016).
- Ueda, J. et al. Control of electron transfer between Ce^{3+} and Cr^{3+} in the $\text{Y}_3\text{Al}_5-x\text{Ga}_x\text{O}_{12}$ host via conduction band engineering. *J. Mater. Chem. C* **3**, 5642–5651 (2015).
- Li, W. H. et al. Tailoring trap depth and emission wavelength in $\text{Y}_3\text{Al}_5-x\text{Ga}_x\text{O}_{12}:\text{Ce}^{3+}, \text{V}^{3+}$ phosphor-in-glass films for optical information storage. *ACS Appl. Mater. Interfaces* **10**, 27150–27159 (2018).
- Liu, Y. F. et al. A two-step solid-state reaction to synthesize the yellow persistent $\text{Gd}_3\text{Al}_2\text{Ga}_3\text{O}_{12}:\text{Ce}^{3+}$ phosphor with an enhanced optical performance for AC-LEDs. *Chem. Commun.* **53**, 10636–10639 (2017).
- Lin, H. et al. $\text{Lu}_2\text{CaMg}_2(\text{Si}_{1-x}\text{Ge}_x)_3\text{O}_{12}:\text{Ce}^{3+}$ solid-solution phosphors: bandgap engineering for blue-light activated afterglow applicable to AC-LED. *J. Mater. Chem. C* **4**, 10329–10338 (2016).
- Lin, H. et al. Bandgap tailoring via Si doping in inverse-garnet $\text{Mg}_3\text{Y}_2\text{Ge}_3\text{O}_{12}:\text{Ce}^{3+}$ persistent phosphor potentially applicable in AC-LED. *ACS Appl. Mater. Interfaces* **7**, 21835–21843 (2015).
- Zhang, H. J. et al. Yellow-light afterglow material, manufacturing method thereof and LED luminescence device using the same. *EU patent 074*, 860 (2009).
- Shannon, R. D. Revised effective ionic radii and systematic studies of interatomic distances in halides and chalcogenides. *Acta Crystallogr. Sect. A: Found. Adv.* **32**, 751–767 (1976).
- Zeng, H. et al. Two-site occupation for exploring ultra-broadband near-infrared phosphor—double-perovskite $\text{La}_2\text{Mg}_2\text{ZrO}_6:\text{Cr}^{3+}$. *Chem. Mater.* **31**, 5245–5253 (2019).
- Wei, Y. et al. New strategy for designing orangish-red-emitting phosphor via oxygen-vacancy-induced electronic localization. *Light: Sci. Appl.* **8**, 15 (2019).
- Zhou, Y. N. et al. Cyan-green phosphor ($\text{Lu}_2\text{M}(\text{Al}_4\text{Si})\text{O}_{12}:\text{Ce}^{3+}$) for high-quality LED lamp: tunable photoluminescence properties and enhanced thermal stability. *Inorg. Chem.* **58**, 1492–1500 (2019).
- Ji, X. Y. et al. Improving quantum efficiency and thermal stability in blue-emitting $\text{Ba}_{2-x}\text{Sr}_x\text{SiO}_4:\text{Ce}^{3+}$ phosphor via solid solution. *Chem. Mater.* **30**, 5137–5147 (2018).
- Zhu, Q. Q. et al. Extra-broad band orange-emitting Ce^{3+} -doped $\text{Y}_3\text{Si}_5\text{N}_9\text{O}$ phosphor for solid-state lighting: electronic, crystal structures and luminescence properties. *Chem. Mater.* **28**, 4829–4839 (2016).
- Dorenbos, P. Thermal quenching of Eu^{2+} 5d–4f luminescence in inorganic compounds. *J. Phys.: Condens. Matter* **17**, 8103–8111 (2005).
- Lin, Y. C., Bettinelli, M. & Karlsson, M. Unraveling the mechanisms of thermal quenching of luminescence in Ce^{3+} -doped garnet phosphors. *Chem. Mater.* **31**, 3851–3862 (2019).
- Lin, Y. C. et al. Unraveling the impact of different thermal quenching routes on the luminescence efficiency of the $\text{Y}_3\text{Al}_5\text{O}_{12}:\text{Ce}^{3+}$ phosphor for white light emitting diodes. *J. Mater. Chem. C* **8**, 14015–14027 (2020).
- Ueda, J., Maki, R. & Tanabe, S. Vacuum referred binding energy (VRBE)-guided design of orange persistent $\text{Ca}_3\text{Si}_2\text{O}_7:\text{Eu}^{2+}$ phosphors. *Inorg. Chem.* **56**, 10353–10360 (2017).
- Ueda, J., Tanabe, S. & Nakanishi, T. Analysis of Ce^{3+} luminescence quenching in solid solutions between $\text{Y}_3\text{Al}_5\text{O}_{12}$ and $\text{Y}_3\text{Ga}_5\text{O}_{12}$ by temperature dependence of photoconductivity measurement. *J. Appl. Phys.* **110**, 053102 (2011).
- Viswanath, N. S. M. et al. A new persistent blue-emitting phosphor: tailoring the trap density for enhancing the persistent time. *Appl. Mater. Today* **18**, 100518 (2020).
- Lai, X. H. et al. Structure and luminescence properties of Ce^{3+} -activated $\text{BaLu}_2\text{Al}_2\text{Ga}_2\text{SiO}_{12}$ persistent phosphors for optical information storage. *Optical Mater.* **120**, 111391 (2021).
- Ju, G. F. et al. Concentration quenching of persistent luminescence. *Phys. B: Condens. Matter.* **415**, 1–4 (2013).
- Fei, Q., Chang, C. K. & Mao, D. L. Luminescent properties of $\text{Sr}_2\text{MgSi}_2\text{O}_7$ and $\text{Ca}_2\text{MgSi}_2\text{O}_7$ long lasting phosphors activated by $\text{Eu}^{2+}, \text{Dy}^{3+}$. *J. Alloy. Compd.* **390**, 133–137 (2005).
- Awater, R. H. P., Niemeijer-Berghuijs, L. C. & Dorenbos, P. Luminescence and charge carrier trapping in $\text{YPO}_4:\text{Bi}$. *Optical Mater.* **66**, 351–355 (2017).
- Awater, R. H. P. & Dorenbos, P. X-ray induced valence change and vacuum referred binding energies of Bi^{3+} and Bi^{2+} in $\text{Li}_2\text{BaP}_2\text{O}_7$. *J. Phys. Chem. C* **120**, 15114–15118 (2016).
- Singh, G., Kumar, M. & Vaish, R. Promising multicatalytic and adsorption capabilities in $\text{V}_2\text{O}_5/\text{BiVO}_4$ composite pellets for water-cleaning application. *Surf. Interfaces* **23**, 100924 (2021).
- Li, X. et al. Mechanism of crystal structure transformation and abnormal reduction in $\text{Ca}_{5-x}(\text{BO}_3)_{3-x}(\text{PO}_4)_x\text{F}$ (CBP_xF): yBi^{3+} . *Inorg. Chem.* **57**, 13783–13799 (2018).

42. Qin, X. X. et al. A novel NIR long phosphorescent phosphor: SrSnO₃: Bi²⁺. *RSC Adv.* **5**, 101347–101352 (2015).
43. Pang, R. et al. Luminescence properties of a novel reddish orange long-lasting phosphorescence phosphor Zn₂P₂O₇: Sm³⁺, Li⁺. *RSC Adv.* **5**, 82704–82710 (2015).
44. Randall, J. T. & Wilkins, M. H. F. Phosphorescence and electron traps-I. The study of trap distributions. *Proc. R. Soc. Lond., Ser. A* **184**, 366–389 (1945).
45. Pitale, S. S. et al. TL and PL studies on defect-assisted green luminescence from doped strontium sulfide phosphor. *J. Lumin.* **128**, 1587–1594 (2008).
46. Van Den Eeckhout, K. et al. Revealing trap depth distributions in persistent phosphors. *Phys. Rev. B* **87**, 045126 (2013).
47. Zhang, Y. et al. Germanium substitution endowing Cr³⁺-doped zinc aluminate phosphors with bright and super-long near-infrared persistent luminescence. *Acta Materialia* **155**, 214–221 (2018).
48. Yuan, W. H. et al. Intense UV long persistent luminescence benefiting from the coexistence of Pr³⁺/Pr⁴⁺ in a praseodymium-doped BaLu₂Al₂Ga₂SiO₁₂ phosphor. *J. Mater. Chem. C* **9**, 5206–5216 (2021).
49. Hai, O. et al. Insights into the element gradient in the grain and luminescence mechanism of the long afterglow material Sr₂MgSi₂O₇: Eu²⁺, Dy³⁺. *J. Alloy. Compd.* **779**, 892–899 (2019).